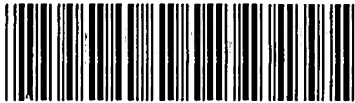


Search Notes

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10/604,118

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

HEINEMAN ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
Updated		8/17/2007	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR